Notice of References Cited Application/Control No. 10/604,788 Examiner Cheukfan Lee Applicant(s)/Patent Under Reexamination KUAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,079,791	07-2006	Chang et al.	399/220
*	В	US-2005/0041269 A	02-2005	Tsuboi, Yoshihito	358/474
*	С	US-2007/0097386 A	05-2007	Tregoning et al.	358/001.6
*	D	US-2002/0008850 A	01-2002	Noji et al.	353/30
	Е	US-			
	F	US-			
	G	US-			
- 1	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02107055 A	04-1990	Japan	ICHINOSE, SHUICHI	
	0	JP 03182157 A	08-1991	Japan	ICHINOSE, SHUICHI	·
	P.					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ					
	V					
	w					
	×					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.